

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-03226.1	SERIAL NO. <u>10/728268</u> To Be Assigned
	APPLICANT Naoki INOUE et al.	
	FILING DATE Here with <u>12/4/03</u>	GROUP To Be Assigned <u>2652</u>

LIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

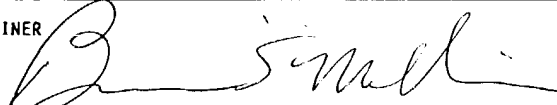
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	5,278,717	01/11/94	Sasaki et al.	360	133	
	AB	6,021,031	02/01/00	Hales et al.	360	133	
	AC	4,586,102	04/29/86	Bresson	360	133	
	AD	4,471,397	09/1984	Cloutier, Robert P.	360	133	
	AE	4,724,962	02/1988	Watanabe et al.	360	133	
	AF	5,537,389	07/1996	Kuwa et al.	369	291	
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	AH	6,111,726	08/2000	Clark et al.	360	133	
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	AJ	6,356,527	03/2002	Shiomi et al.	369	291	
	AK	6,473,392	10/2002	Shiomi et al.	369	291	

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	AL	JP 11 345475	12/14/99	Japan			
	AM	2000-30394	01/2000	Japan			
	AN						
	AO						
	AP						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AQ		PATENT ABSTRACTS OF JAPAN vol. 2000, no. 03, 30 March 2000 (2000-03-30)

EXAMINER 	DATE CONSIDERED <u>7/12/04</u>
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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